

# NCE P-Channel Enhancement Mode Power MOSFET

#### Description

The NCE01P13K uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. It can be used in a wide variety of applications. It is ESD protested.

#### **General Features**

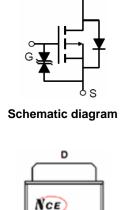
- V<sub>DS</sub> =-100V,I<sub>D</sub> =-13A
  R<sub>DS(ON)</sub> <200mΩ @ V<sub>GS</sub>=-10V (Typ:170mΩ)
- Super high dense cell design
- Advanced trench process technology
- Reliable and rugged
- High density celldesign for ultra low on-resistance

#### Application

- Power switch
- DC/DC converters

#### 100% UIS TESTED!

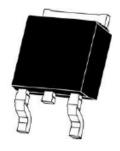
#### **100% ΔVds TESTED!**



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#### Marking and pin assignment



TO-252 -2Ltop view

#### **Package Marking and Ordering Information**

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
NCE01P13K	NCE01P13K	TO-252-2L	-	-	-

#### Absolute Maximum Ratings (Tc=25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	Vds	-100	V
Gate-Source Voltage	Vgs	±20	V
Drain Current-Continuous	I <sub>D</sub>	-13	А
Drain Current-Continuous(T <sub>C</sub> =100℃)	I <sub>D</sub> (100℃)	-9.2	A
Pulsed Drain Current	I <sub>DM</sub>	-52	A
Maximum Power Dissipation	PD	40	W
Derating factor		0.27	<b>W</b> /℃
Single pulse avalanche energy (Note 5)	E <sub>AS</sub>	110	mJ
Operating Junction and Storage Temperature Range	T <sub>J</sub> ,T <sub>STG</sub>	-55 To 175	്റ
Thermal Characteristic			
Thermal Resistance, Junction-to-Case (Note 2)	R <sub>θJc</sub>	3.75	°C <b>/W</b>



### Electrical Characteristics (T<sub>c</sub>=25 $^{\circ}$ Cunless otherwise noted)

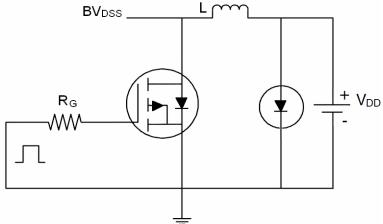
Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics	•	·	•			
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =-250µA	-100	-	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =-100V,V <sub>GS</sub> =0V	-	-	1	μA
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V,V <sub>DS</sub> =0V	-	-	±10	μA
On Characteristics (Note 3)						
Gate Threshold Voltage	$V_{GS(th)}$	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =-250µA	-1	-1.9	-3	V
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =-10V, I <sub>D</sub> =-10A	-	170	200	mΩ
Forward Transconductance	<b>g</b> fs	V <sub>DS</sub> =-5V,I <sub>D</sub> =-5A	12	-	-	S
Dynamic Characteristics (Note4)		·	•			
Input Capacitance	C <sub>lss</sub>		-	1734	-	PF
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> =-50V,V <sub>GS</sub> =0V, F=1.0MHz	-	86	-	PF
Reverse Transfer Capacitance	C <sub>rss</sub>	+=1.0MHz -		40	-	PF
Switching Characteristics (Note 4)		·	•			
Turn-on Delay Time	t <sub>d(on)</sub>		-	12	-	nS
Turn-on Rise Time	tr	V <sub>DD</sub> =-50V,I <sub>D</sub> =-10A V <sub>GS</sub> =-10V,R <sub>GEN</sub> =9.1Ω	-	52	-	nS
Turn-Off Delay Time	t <sub>d(off)</sub>		-	28	-	nS
Turn-Off Fall Time	t <sub>f</sub>		-	38	-	nS
Total Gate Charge	Qg	$y_{1} = 50y_{1} = 400$	-	33.1	-	nC
Gate-Source Charge	Q <sub>gs</sub>	- V <sub>DS</sub> =-50V,I <sub>D</sub> =-10A,	-	4.2	-	nC
Gate-Drain Charge	Q <sub>gd</sub>	V <sub>GS</sub> =-10V	-	7.1	-	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage (Note 3)	V <sub>SD</sub>	V <sub>GS</sub> =0V,I <sub>S</sub> =-10A	-	-	-1.2	V
Diode Forward Current (Note 2)	ls	-	-	-	-13	Α
Reverse Recovery Time	t <sub>rr</sub>	TJ = 25°C, IF =-10A	-	35	-	nS
Reverse Recovery Charge	Qrr	di/dt = 100A/µs <sup>(Note3)</sup>	-	46	-	nC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

#### Notes:

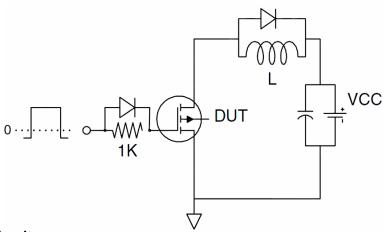
- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- **2.** Surface Mounted on FR4 Board, t  $\leq$  10 sec.
- **3.** Pulse Test: Pulse Width  $\leq$  300µs, Duty Cycle  $\leq$  2%.
- 4. Guaranteed by design, not subject to production
- 5. EAS condition: Tj=25 $^\circ C, V_{DD}$ =-50V, V\_G=-10V, L=0.5mH, Rg=25 $\Omega$



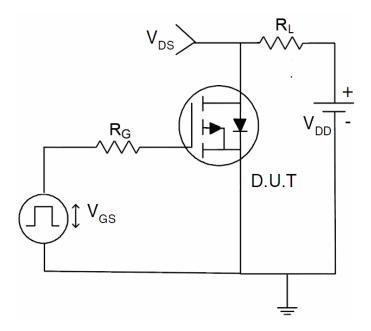
## Test Circuit 1) E<sub>AS</sub> Test Circuit



## 2) Gate Charge Test Circuit

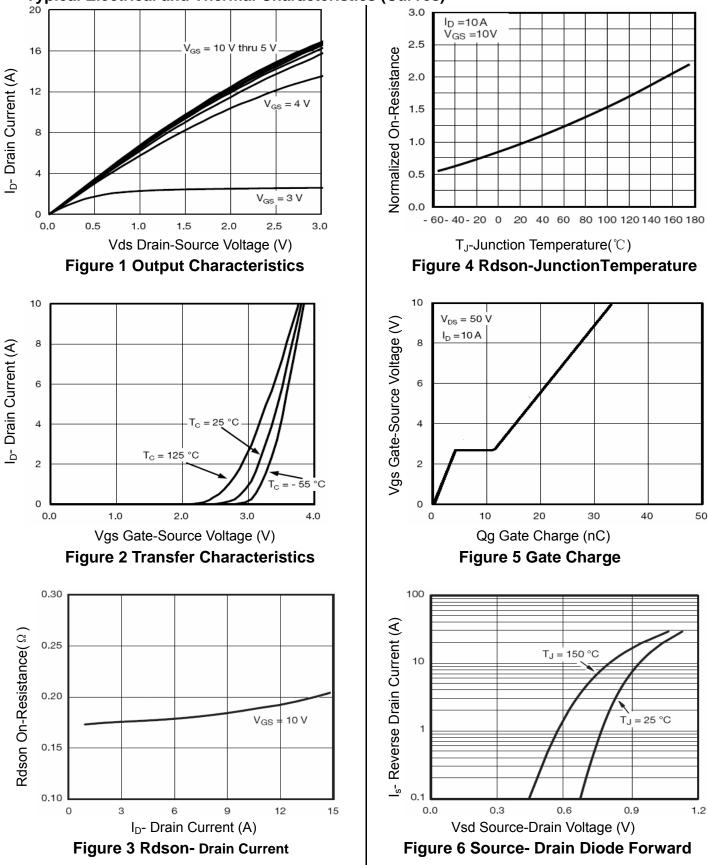


3) Switch Time Test Circuit











http://www.ncepower.com

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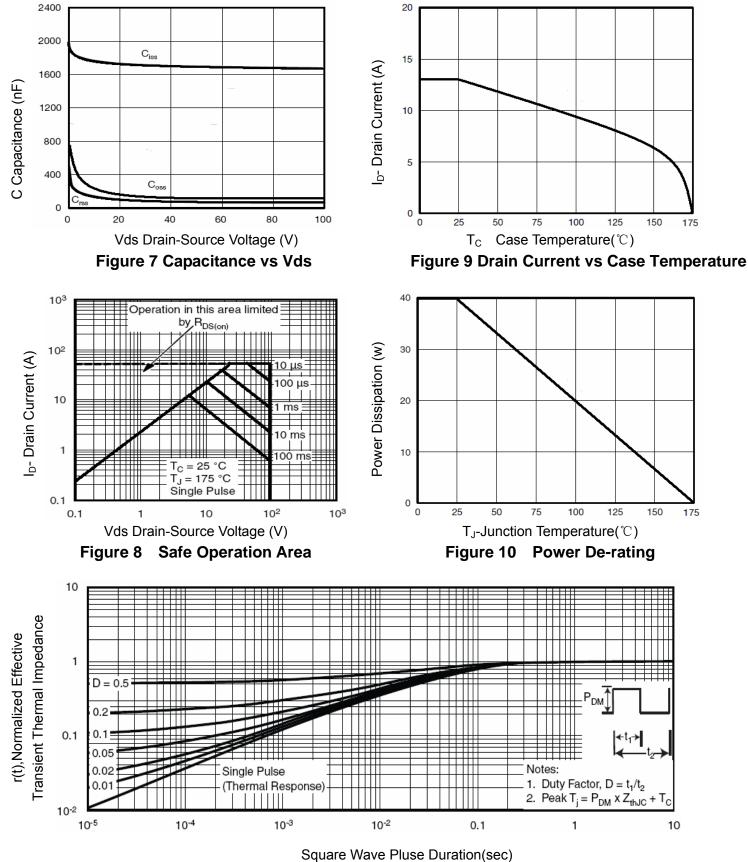
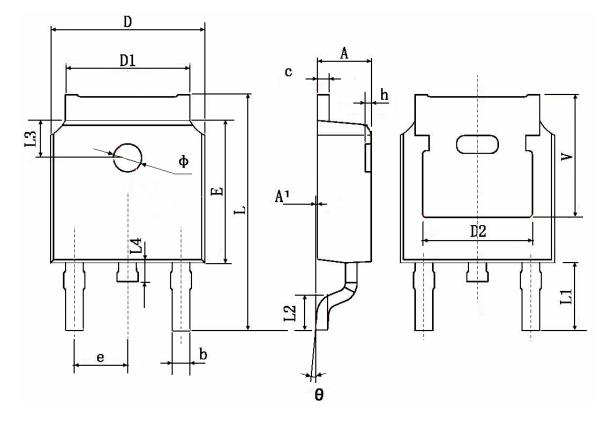


Figure 11 Normalized Maximum Transient Thermal Impedance



## **TO-252 Package Information**



Querra la cal	Dimensions	In Millimeters	Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
А	2.200	2.400	0.087	0.094	
A1	0.000	0.127	0.000	0.005	
b	0.660	0.860	0.026	0.034	
С	0.460	0.580	0.018	0.023	
D	6.500	6.700	0.256	0.264	
D1	5.100	5.460	0.201	0.215	
D2	4.830	D TYP.	0.190 TYP.		
E	6.000	6.200	0.236	0.244	
е	2.186	2.386	0.086	0.094	
L	9.800	10.400	0.386	0.409	
L1	2.900 TYP.		0.114 TYP.		
L2	1.400	1.700	0.055	0.067	
L3	1.60	D TYP.	0.063 TYP.		
L4	0.600	1.000	0.024	0.039	
Φ	1.100	1.300	0.043	0.051	
θ	0°	8°	0°	8°	
h	0.000	0.300	0.000	0.012	
V	5.35	D TYP.	0.211 TYP.		



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